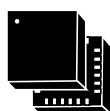


## High-performance motion sensor for automotive applications: ultra-low-power digital output 3-axis accelerometer

Datasheet - production data



QFN 24 (4x4x1.8 mm3)

### Features

- Wide supply voltage range: 2.4 V to 3.6 V
- 1.8 V low voltage compatible IOs
- Ultra-low-power mode consumption down to 10  $\mu$ A
- $\pm 6g/\pm 12g/\pm 24g$  dynamically selectable full scale
- SPI/I<sup>2</sup>C digital output interface
- 16-bit data output, 12-bit resolution
- 2 independent programmable interrupt generators
- System sleep-to-wake function
- Embedded self-test
- Extended temperature range -40°C to 105°C
- 10000 g high shock survivability
- ECOPACK<sup>®</sup>, RoHS and “Green” compliant (see [Section 8](#))
- AEC-Q100 qualification

### Description

The AIS3624DQ is an ultra-low-power high-performance three-axis accelerometer with a digital serial interface SPI standard output, an I<sup>2</sup>C compatible interface is also available.

The device features ultra-low-power operational modes that allow advanced power saving and smart sleep-to-wake functions.

The AIS3624DQ has dynamically user selectable full scales of  $\pm 6g/\pm 12g/\pm 24g$  and it is capable of measuring accelerations with output data rates from 0.5 Hz to 1 kHz.

The self-test capability allows the user to check the functioning of the sensor in the final application.

The device may be configured to generate an interrupt signal by inertial wakeup/free-fall events as well as by the position of the device itself. Thresholds and timing of interrupt generators are programmable by the end user on the fly.

The AIS3624DQ is available in small, quad flat no-lead package (QFN) with the reduced 4x4 mm footprint required by many applications and it is guaranteed to operate over an extended temperature range from -40 °C to +105 °C.

This product may be used in a variety of automotive non-safety applications such as:

- Motion-activated functions
- Telematic boxes
- Impact recognition and logging systems
- Vibration monitoring and compensation

Table 1. Device summary

| Order codes | Temperature range [°C] | Package         | Packaging     |
|-------------|------------------------|-----------------|---------------|
| AIS3624DQ   | -40 to +105            | QFN 4x4x1.8 24L | Tray          |
| AIS3624DQTR | -40 to +105            | QFN 4x4x1.8 24L | Tape and reel |

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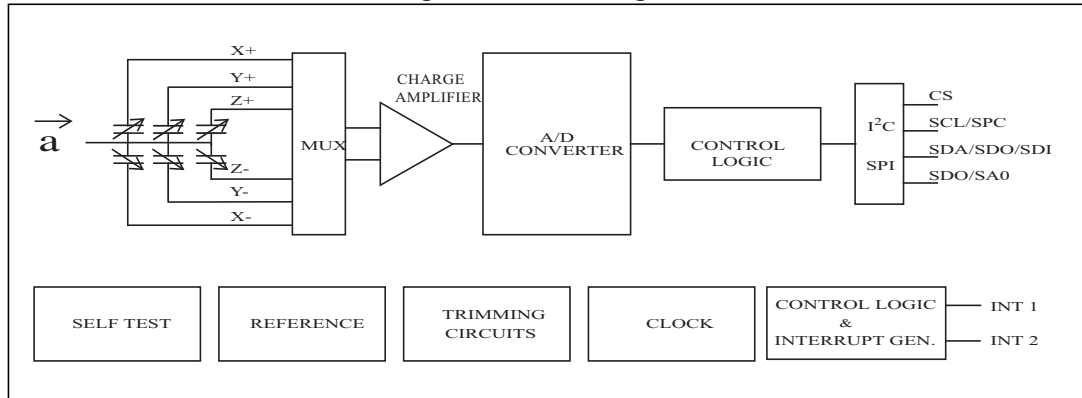
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# 1 Block diagram and pin description

## 1.1 Block diagram

Figure 1. Block diagram



## 1.2 Pin description

Figure 2. Pin connections

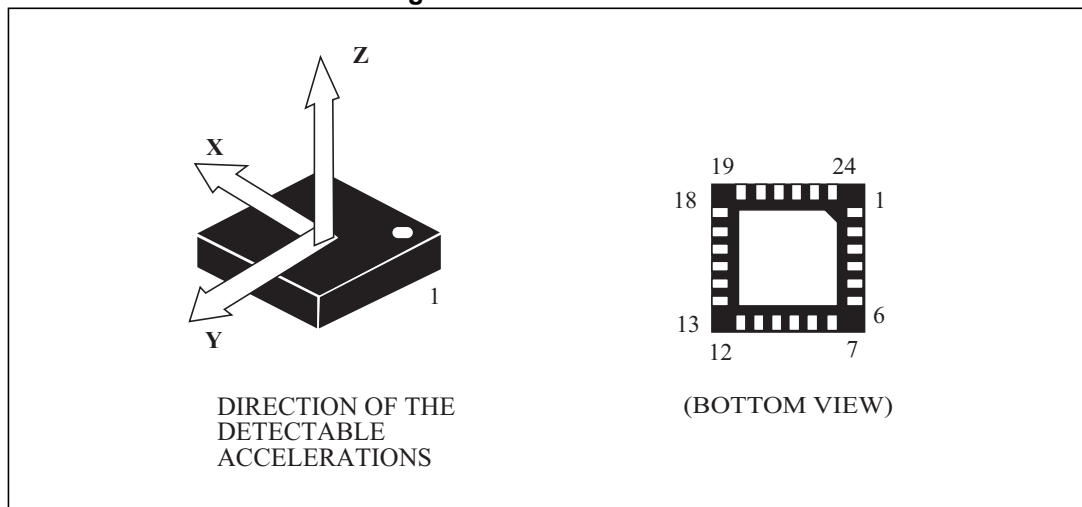




Table 2. Pin description

| Pin#  | Name              | Function   |
|-------|-------------------|--|
| 1,2   | NC                | Not connected  |
| 3     | INT_2             | Inertial interrupt 2   |
| 4     | Reserved          | Connect to GND   |
| 5     | VDD               | Power supply   |
| 6     | GND               | 0 V supply   |
| 7     | INT_1             | Inertial interrupt 1   |
| 8     | GND               | 0 V supply   |
| 9     | GND               | 0 V supply   |
| 10    | GND               | 0 V supply   |
| 11    | SPC<br>SCL        | SPI serial port clock (SPC)<br>I <sup>2</sup> C serial clock (SCL)   |
| 12    | CS                | SPI enable<br>I <sup>2</sup> C/SPI mode selection (0: SPI enabled; 1: I <sup>2</sup> C mode)                   |
| 13    | Reserved          | Connect to Vdd   |
| 14    | VDD_IO            | Power supply for I/O pins  |
| 15    | SDO<br>SA0        | SPI serial data output (SDO)<br>I <sup>2</sup> C less significant bit of the device address (SA0)              |
| 16    | SDI<br>SDO<br>SDA | SPI serial data input (SDI)<br>3-wire interface serial data output (SDO)<br>I <sup>2</sup> C serial data (SDA) |
| 17-24 | NC                | Not internally connected   |

## 2 Mechanical and electrical specifications

### 2.1 Mechanical characteristics

**Table 3. Mechanical characteristics @ Vdd = 3.3 V, T = -40 °C to +105 °C unless otherwise noted <sup>(1)</sup>**

| Symbol | Parameter   | Test conditions                           | Min.   | Typ. | Max.  | Unit     |
|--------|---|---|--------|------|-------|----------|
| FS     | Measurement range <sup>(2)</sup>                        | FS bit set to 00                          |        | ±6   |       | g        |
|        |   | FS bit set to 01                          |        | ±12  |       |          |
|        |   | FS bit set to 11                          |        | ±24  |       |          |
| So     | Sensitivity   | FS bit set to 00<br>12-bit representation | 2.55   | 2.9  | 3.25  | mg/digit |
|        |   | FS bit set to 01<br>12-bit representation | 5.19   | 5.9  | 6.61  |          |
|        |   | FS bit set to 11<br>12-bit representation | 10.29  | 11.7 | 13.11 |          |
| Off    | Zero-g level offset accuracy <sup>(3),(4),(5)</sup>     | X, Y axes                                 | -500   |      | 500   | mg       |
|        |   | Z-axis                                    | -950   |      | 950   |          |
| TyOff  | Typical zero-g level offset accuracy <sup>(6),(7)</sup> | FS bit set to 00                          | -90    | ±70  | 90    | mg       |
| TCOff  | Zero-g level change vs temperature                      | Max delta from 25 °C (X, Y axes)          | -5     | ±0.4 | 5     | mg/°C    |
|        |   | Max delta from 25 °C (Z-axis)             | -11.25 |      | 11.25 |          |
| An     | Acceleration noise density                              | FS bit set to 00                          |        | 600  | 1500  | µg/√Hz   |
| Vst    | Self-test output change <sup>(8),(9),(10)</sup>         | FS bit set to 00<br>X-axis                | -40    | -270 | -500  | LSb      |
|        |   | FS bit set to 00<br>Y-axis                | 40     | 270  | 500   | LSb      |
|        |   | FS bit set to 00<br>Z-axis                | 120    | 510  | 900   | LSb      |
| Top    | Operating temperature range                             |   | -40    |      | +105  | °C       |
| Wh     | Product weight  |   |        | 55   |       | mgram    |

- The product is factory calibrated at 3.3 V. Operational power supply (Vdd) over 3.6 V it is not recommended.
- Verified by wafer level test and measurement of initial offset and sensitivity
- Typical zero-g level offset value after MSL3 preconditioning
- Offset can be eliminated by enabling the built-in high-pass filter
- Typical zero-g level offset value after MSL3 preconditioning
- Typical zero-g level offset value after MSL3 preconditioning
- Offset can be eliminated by enabling the built-in high-pass filter
- The sign of "Self-test output change" is defined by a sign bit, for all axes.
- Self-test output changes with the power supply. "Self-test output change" is defined as  $OUTPUT[LSb]_{(CTRL\_REG4\ ST\ bit=1)} - OUTPUT[LSb]_{(CTRL\_REG4\ ST\ bit=0)}$ . 1LSb=12g/4096 at 12-bit representation, ±6 g full scale
- Output data reach 99% of final value after 1/ODR+1ms when enabling self-test mode, due to device filtering

## 2.2 Electrical characteristics

**Table 4. Electrical characteristics @ Vdd = 3.3 V, T = -40 °C to +105 °C unless otherwise noted <sup>(1)</sup>**

| Symbol            | Parameter                              | Test conditions             | Min.             | Typ.           | Max.             | Unit |
|-------------------|--|-----------------------------|------------------|----------------|------------------|------|
| Vdd               | Supply voltage                         |                             | 2.4              | 3.3            | 3.6              | V    |
| Vdd_IO            | I/O pins supply voltage <sup>(2)</sup> |                             | 1.8              |                | Vdd+0.1          | V    |
| Idd               | Current consumption in normal mode     | 2.4 V to 3.6 V              | 200              |                | 450              | μA   |
| IddLP             | Current consumption in low-power mode  | ODR=1 Hz, BW=500 Hz, T=25°C | 8                | 10             | 12               | μA   |
| IddPdn            | Current consumption in power-down mode |                             | 0.1              | 1              | 2                | μA   |
| VIH               | Digital high-level input voltage       |                             | 0.8*Vdd_IO       |                |                  | V    |
| VIL               | Digital low-level input voltage        |                             |                  |                | 0.2*Vdd_IO       | V    |
| VOH               | High-level output voltage              |                             | 0.9*Vdd_IO       |                |                  | V    |
| VOL               | Low-level output voltage               |                             |                  |                | 0.1*Vdd_IO       | V    |
| ODR               | Output data rate in normal mode        | DR bit set to 00            |                  | 50             |                  | Hz   |
|                   |  | DR bit set to 01            |                  | 100            |                  |      |
|                   |  | DR bit set to 10            |                  | 400            |                  |      |
|                   |  | DR bit set to 11            |                  | 1000           |                  |      |
| ODR <sub>LP</sub> | Output data rate in low-power mode     | PM bit set to 010           |                  | 0.5            |                  | Hz   |
|                   |  | PM bit set to 011           |                  | 1              |                  |      |
|                   |  | PM bit set to 100           |                  | 2              |                  |      |
|                   |  | PM bit set to 101           |                  | 5              |                  |      |
|                   |  | PM bit set to 110           |                  | 10             |                  |      |
| BW                | System bandwidth                       |                             |                  | ODR/2          |                  | Hz   |
| Ton               | Turn-on time <sup>(3)</sup>            | ODR = 100 Hz                | 0.9/ODR+<br>1 ms | 1/ODR+<br>1 ms | 1.1/ODR+<br>1 ms | s    |
| Top               | Operating temperature range            |                             | -40              |                | +105             | °C   |

1. The product is factory calibrated at 3.3 V. Operational power supply (Vdd) over 3.6 V is not recommended.
2. It is possible to remove Vdd maintaining Vdd\_IO without blocking the communication busses, in this condition the measurement chain is powered off.
3. Time to obtain valid data after exiting power-down mode

## 2.3 Communication interface characteristics

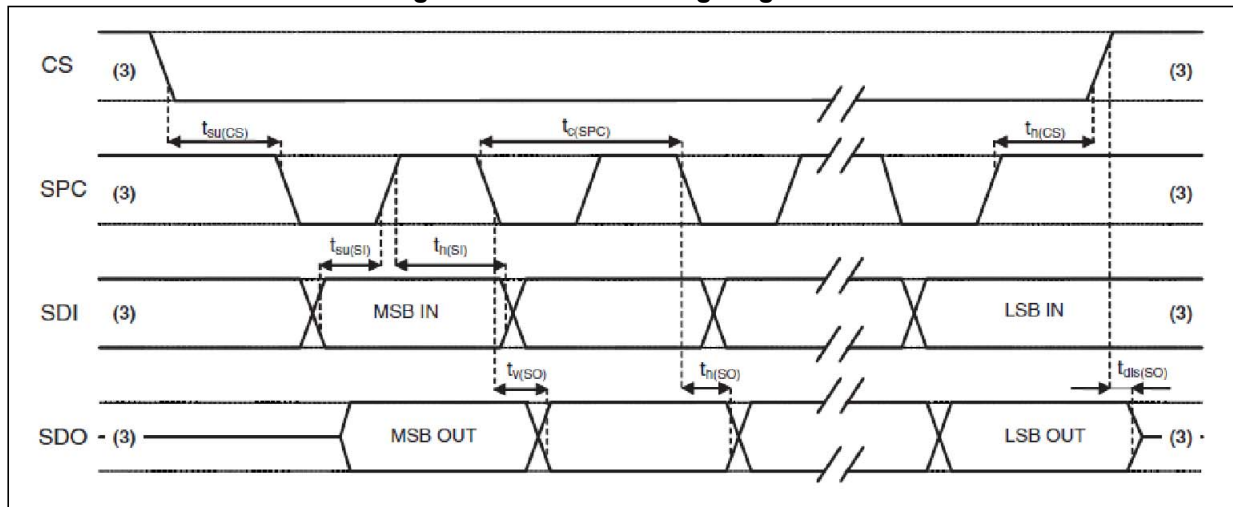
### 2.3.1 SPI - serial peripheral interface

Subject to general operating conditions for Vdd and Top.

Table 5. SPI slave timing values

| Symbol        | Parameter               | Value <sup>(1)</sup> |     | Unit |
|---------------|-------------------------|----------------------|-----|------|
|               |                         | Min                  | Max |      |
| $t_{c(SPC)}$  | SPI clock cycle         | 100                  |     | ns   |
| $f_{c(SPC)}$  | SPI clock frequency     |                      | 10  | MHz  |
| $t_{su(CS)}$  | CS setup time           | 6                    |     | ns   |
| $t_{h(CS)}$   | CS hold time            | 8                    |     |      |
| $t_{su(SI)}$  | SDI input setup time    | 5                    |     |      |
| $t_{h(SI)}$   | SDI input hold time     | 15                   |     |      |
| $t_{v(SO)}$   | SDO valid output time   |                      | 50  |      |
| $t_{h(SO)}$   | SDO output hold time    | 9                    |     |      |
| $t_{dis(SO)}$ | SDO output disable time |                      | 50  |      |

Figure 3. SPI slave timing diagram <sup>(2)</sup>



1. Values are guaranteed at 10 MHz clock frequency for SPI with both 4 and 3 wires, based on characterization results, not tested in production.
2. Measurement points are done at 0.2·Vdd\_IO and 0.8·Vdd\_IO, for both input and output ports.
3. When no communication is ongoing, data on CS, SPC, SDI and SDO are driven by internal pull-up resistors.

### 2.3.2 I<sup>2</sup>C - inter-IC control interface

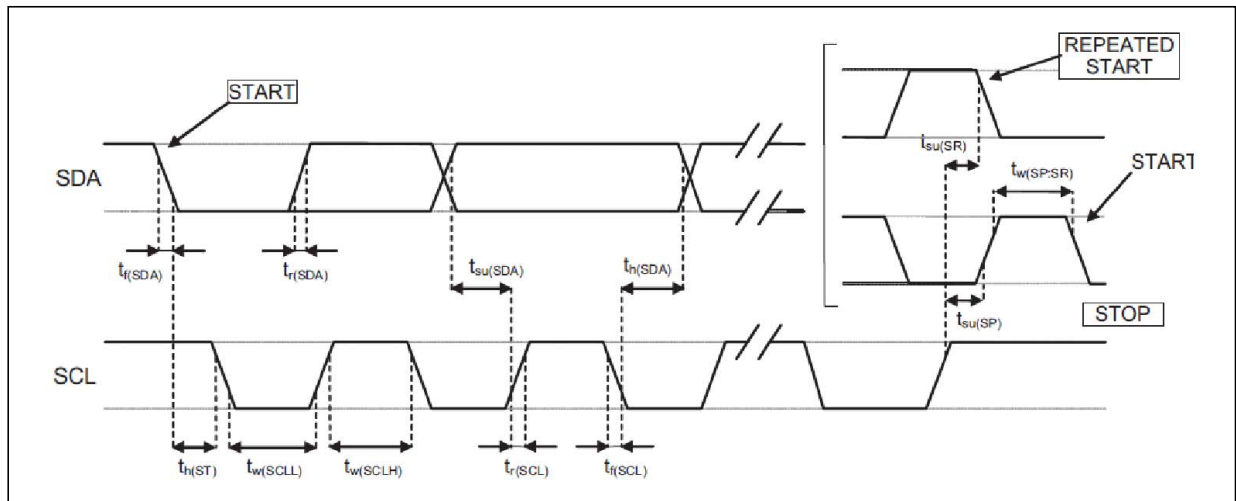
Subject to general operating conditions for Vdd and top.

**Table 6. I<sup>2</sup>C slave timing values**

| Symbol                | Parameter                                      | I <sup>2</sup> C standard mode <sup>(1)</sup> |      | I <sup>2</sup> C fast mode <sup>(1)</sup> |     | Unit |
|-----------------------|--|---|------|---|-----|------|
|                       |  | Min   | Max  | Min                                       | Max |      |
| f <sub>(SCL)</sub>    | SCL clock frequency                            | 0   | 100  | 0   | 400 | KHz  |
| t <sub>w(SCLL)</sub>  | SCL clock low time                             | 4.7   |      | 1.3                                       |     | μs   |
| t <sub>w(SCLH)</sub>  | SCL clock high time                            | 4.0   |      | 0.6                                       |     |      |
| t <sub>su(SDA)</sub>  | SDA setup time                                 | 250   |      | 100                                       |     | ns   |
| t <sub>h(SDA)</sub>   | SDA data hold time                             | 0.01  | 3.45 | 0.01                                      | 0.9 | μs   |
| t <sub>h(ST)</sub>    | START condition hold time                      | 4   |      | 0.6                                       |     | μs   |
| t <sub>su(SR)</sub>   | Repeated START condition setup time            | 4.7   |      | 0.6                                       |     |      |
| t <sub>su(SP)</sub>   | STOP condition setup time                      | 4   |      | 0.6                                       |     |      |
| t <sub>w(SP:SR)</sub> | Bus free time between STOP and START condition | 4.7   |      | 1.3                                       |     |      |

1. Data based on standard I<sup>2</sup>C protocol requirement, not tested in production

**Figure 4. I<sup>2</sup>C slave timing diagram<sup>(a)</sup>**



a. Measurement points are done at 0.2·Vdd\_IO and 0.8·Vdd\_IO, for both ports.

## 2.4 Absolute maximum ratings

Stresses above those listed as “absolute maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 7. Absolute maximum ratings**

| Symbol             | Ratings  | Maximum value                   | Unit |
|--------------------|--|---------------------------------|------|
| V <sub>dd</sub>    | Supply voltage   | -0.3 to 4                       | V    |
| V <sub>dd_IO</sub> | I/O pins supply voltage  | -0.3 to V <sub>dd</sub> +0.1    | V    |
| V <sub>in</sub>    | Input voltage on any control pin (CS, SCL/SPC, SDA/SDI/SDO, SDO/SA0) | -0.3 to V <sub>dd_IO</sub> +0.3 | V    |
| A <sub>POW</sub>   | Acceleration (any axis, powered, V <sub>dd</sub> = 2.5 V)            | 3000 g for 0.5 ms               |      |
|                    |  | 10000 g for 0.1 ms              |      |
| A <sub>UNP</sub>   | Acceleration (any axis, unpowered)                                   | 3000 g for 0.5 ms               |      |
|                    |  | 10000 g for 0.1 ms              |      |
| T <sub>OP</sub>    | Operating temperature range  | -40 to +105                     | °C   |
| T <sub>STG</sub>   | Storage temperature range  | -40 to +125                     | °C   |
| ESD                | Electrostatic discharge protection                                   | 2 (HBM)                         | kV   |
|                    |  | 500 (CDM)                       | V    |
|                    |  | 200 (MM)                        | V    |

*Note:* Supply voltage on any pin should never exceed 4.0 V



This device is sensitive to mechanical shock, improper handling can cause permanent damages to the part.



This device is sensitive to electrostatic discharge (ESD), improper handling can cause permanent damages to the part.

## 2.5 Terminology

### 2.5.1 Sensitivity

Sensitivity describes the gain of the sensor and can be determined, for example, by applying 1 g acceleration to it. As the sensor can measure DC accelerations this can be done easily by pointing the axis of interest towards the center of the Earth, noting the output value, rotating the sensor by 180 degrees (pointing to the sky) and noting the output value again. By doing so,  $\pm 1$  g acceleration is applied to the sensor. Subtracting the larger output value from the smaller one, and dividing the result by 2, leads to the actual sensitivity of the sensor. This value changes very little over temperature and time. The sensitivity tolerance describes the range of sensitivities of a large population of sensors.

### 2.5.2 Zero-g level

Zero-g level offset (TyOff) describes the deviation of an actual output signal from the ideal output signal if no acceleration is present. A sensor in a steady state on a horizontal surface will measure 0 g for the X-axis and 0 g for the Y-axis whereas the Z-axis will measure 1 g. The output is ideally in the middle of the dynamic range of the sensor (content of OUT registers 00h, data expressed as 2's complement number). A deviation from the ideal value in this case is called Zero-g offset. Offset is to some extent a result of stress to MEMS sensor and therefore the offset can slightly change after mounting the sensor onto a printed circuit board or exposing it to extensive mechanical stress. Offset changes little over temperature, see "Zero-g level change vs. temperature".

### 2.5.3 Self-test

Self-test allows checking the sensor functionality without moving it. The self-test function is off when the self-test bit (ST) of CTRL\_REG4 (control register 4) is programmed to '0'. When the self-test bit of CTRL\_REG4 is programmed to '1', an actuation force is applied to the sensor, simulating a definite input acceleration. In this case the sensor outputs will exhibit a change in their DC levels which are related to the selected full scale through the device sensitivity. When self-test is activated, the device output level is given by the algebraic sum of the signals produced by the acceleration acting on the sensor and by the electrostatic test-force. If the output signals change within the amplitude specified inside [Table 3](#), then the sensor is working properly and the parameters of the interface chip are within the defined specifications.

### 2.5.4 Sleep-to-wake

The "sleep-to-wakeup" function, in conjunction with low-power mode, allows to further reduce the system power consumption and develop new smart applications. AIS3624DQ may be set in a low-power operating mode, characterized by lower data rate updates. In this way the device, even if sleeping, continues to sense acceleration and generate interrupt requests.

When the "sleep-to-wake" function is activated, AIS3624DQ is able to automatically wake up as soon as the interrupt event has been detected, increasing the output data rate and bandwidth.

With this feature the system may be efficiently switched from low-power mode to full-performance depending on user-selectable positioning and acceleration events, thus ensuring power saving and flexibility.

## 3 Functionality

The AIS3624DQ is a nano, low-power, digital output 3-axis linear accelerometer available or housed in a QFN package. The complete device includes a sensing element and an IC interface. The device comprises a sensing element and an IC interface which communicates through an I<sup>2</sup>C or SPI serial interface from the sensing element to the application.

### 3.1 Sensing element

A proprietary process is used to create a surface micromachined accelerometer. The technology allows processing suspended silicon structures which are attached to the substrate in a few points called anchors and are free to move in the direction of the sensed acceleration. In order to be compatible with traditional packaging techniques, a cap is placed on top of the sensing element to avoid blocking the moving parts during the molding phase of the plastic encapsulation.

When an acceleration is applied to the sensor, the proof mass displaces from its nominal position, causing an imbalance in the capacitive half-bridge. This imbalance is measured using charge integration in response to a voltage pulse applied to the capacitor.

At steady state the nominal value of the capacitors are few pF and when an acceleration is applied the maximum variation of the capacitive load is in the fF range.

### 3.2 IC interface

The complete measurement chain is composed of a low-noise capacitive amplifier which converts the capacitive unbalancing of the MEMS sensor into an analog voltage using an analog-to-digital converter.

The acceleration data may be accessed through an I<sup>2</sup>C/SPI interface thus making the device particularly suitable for direct interfacing with a microcontroller.

The AIS3624DQ features a Data-Ready signal (RDY) which indicates when a new set of measured acceleration data is available, thus simplifying data synchronization in the digital system that uses the device.

The AIS3624DQ may also be configured to generate an inertial wakeup and free-fall interrupt signal according to a programmed acceleration event along the enabled axes. Both free-fall and wakeup can be available simultaneously on two different pins.

### 3.3 Factory calibration

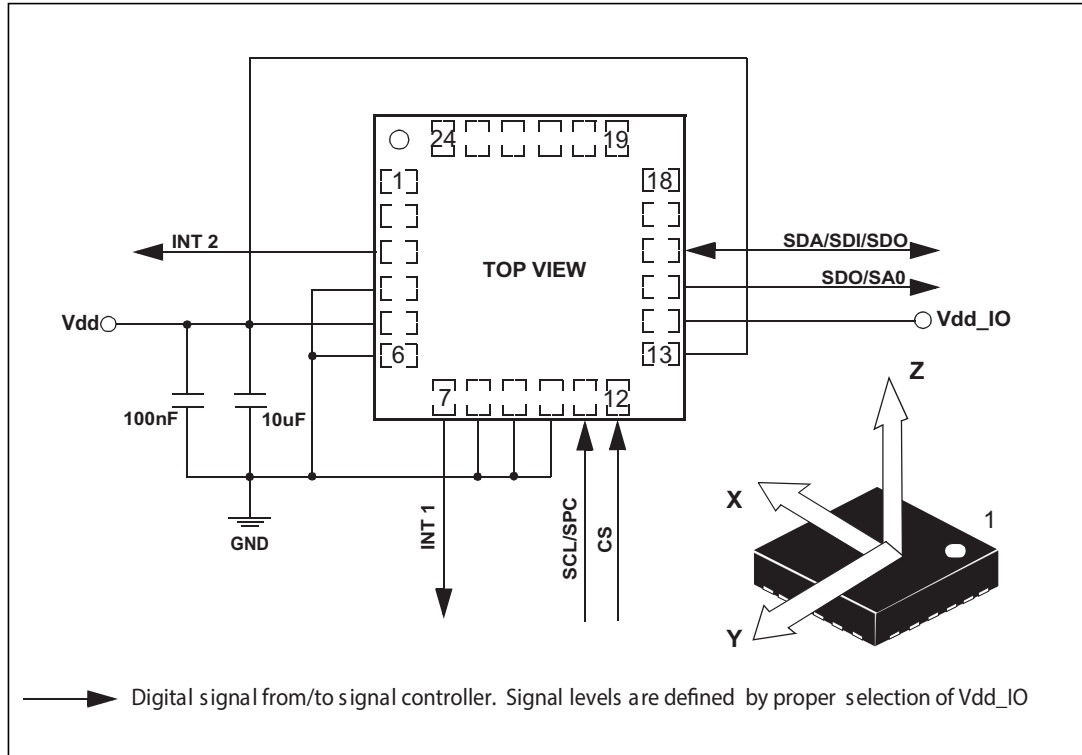
The IC interface is factory calibrated for sensitivity (S<sub>0</sub>) and Zero-g level (T<sub>yOff</sub>).

The trimming values are stored inside the device in a non-volatile memory. Any time the device is turned on, the trimming parameters are downloaded into the registers to be employed during active operation which allows the device to be used without further calibration.



## 4 Application hints

Figure 5. AIS3624DQ electrical connections



The device core is supplied through Vdd line while the I/O pads are supplied through the Vdd\_IO line. Power supply decoupling capacitors (100 nF ceramic, 10  $\mu$ F aluminum) should be placed as near as possible to the pin 14 of the device (common design practice).

All the voltage and ground supplies must be present at the same time to have proper behavior of the IC (refer to [Figure 5](#)). It is possible to remove Vdd while maintaining Vdd\_IO without blocking the communication bus, in this condition the measurement chain is powered off.

The functionality of the device and the measured acceleration data is selectable and accessible through the I<sup>2</sup>C or SPI interfaces. When using the I<sup>2</sup>C, CS must be tied high.

The functions, the threshold and the timing of the two interrupt pins (INT 1 and INT 2) can be completely programmed by the user through the I<sup>2</sup>C/SPI interface.

### 4.1 Soldering information

The QFN package is compliant with the ECOPACK<sup>®</sup>, RoHS and “Green” standard. It is qualified for soldering heat resistance according to JEDEC J-STD-020C.

Leave “Pin 1 Indicator” unconnected during soldering.

Land pattern and soldering recommendations are available at [www.st.com](http://www.st.com).

## 5 Digital interfaces

The registers embedded inside the AIS3624DQ may be accessed through both the I<sup>2</sup>C and SPI serial interfaces. The latter may be SW configured to operate either in 3-wire or 4-wire interface mode.

The serial interfaces are mapped onto the same pads. To select/exploit the I<sup>2</sup>C interface, the CS line must be tied high (i.e. connected to Vdd\_IO).

**Table 8. Serial interface pin description**

| Pin name | Pin description  |
|----------|--|
| CS       | SPI enable<br>I <sup>2</sup> C/SPI mode selection (1: I <sup>2</sup> C mode; 0: SPI enabled) |
| SCL      | I <sup>2</sup> C serial clock (SCL)  |
| SPC      | SPI serial port clock (SPC)  |
| SDA      | I <sup>2</sup> C serial data (SDA)   |
| SDI      | SPI serial data input (SDI)  |
| SDO      | 3-wire interface serial data output (SDO)  |
| SA0      | I <sup>2</sup> C less significant bit of the device address (SA0)                            |
| SDO      | SPI serial data output (SDO)   |

### 5.1 I<sup>2</sup>C serial interface

The AIS3624DQ I<sup>2</sup>C is a bus slave. The I<sup>2</sup>C is employed to write data into registers whose content can also be read back.

The relevant I<sup>2</sup>C terminology is given in the table below.

**Table 9. I<sup>2</sup>C terminology**

| Term        | Description  |
|-------------|--|
| Transmitter | The device which sends data to the bus   |
| Receiver    | The device which receives data from the bus  |
| Master      | The device which initiates a transfer, generates clock signals and terminates a transfer |
| Slave       | The device addressed by the master   |

There are two signals associated with the I<sup>2</sup>C bus: the serial clock line (SCL) and the Serial Data line (SDA). The latter is a bidirectional line used for sending and receiving the data to/from the interface. Both the lines are connected to Vdd\_IO through a pull-up resistor embedded inside the AIS3624DQ. When the bus is free, both the lines are high.

The I<sup>2</sup>C interface is compliant with fast mode (400 kHz) I<sup>2</sup>C standards as well as with the normal mode.

### 5.1.1 I<sup>2</sup>C operation

The transaction on the bus is started through a START (ST) signal. A START condition is defined as a HIGH-to-LOW transition on the data line while the SCL line is held HIGH. After this has been transmitted by the master, the bus is considered busy. The next byte of data transmitted after the start condition contains the address of the slave in the first 7 bits and the eighth bit tells whether the master is receiving data from the slave or transmitting data to the slave. When an address is sent, each device in the system compares the first seven bits after a start condition with its address. If they match, the device considers itself addressed by the master.

The Slave Address (SAD) associated to the AIS3624DQ is 001100xb. The **SDO/SA0** pad can be used to modify the less significant bit of the device address. If the SA0 pad is connected to the voltage supply, LSb is '1' (address 0011001b), else if the SA0 pad is connected to ground, the LSb value is '0' (address 0011000b). This solution permits to connect and address two different accelerometers to the same I<sup>2</sup>C lines.

Data transfer with acknowledge is mandatory. The transmitter must release the SDA line during the acknowledge pulse. The receiver must then pull the data line LOW so that it remains stable low during the HIGH period of the acknowledge clock pulse. A receiver which has been addressed is obliged to generate an acknowledge after each byte of data received.

The I<sup>2</sup>C embedded inside the AIS3624DQ behaves like a slave device and the following protocol must be adhered to. After the start condition (ST) a slave address is sent, once a slave acknowledge (SAK) has been returned, an 8-bit sub-address (SUB) is transmitted: the 7 LSb represent the actual register address while the MSB enables address auto increment. If the MSb of the SUB field is '1', the SUB (register address) is automatically increased to allow multiple data read/write.

The slave address is completed with a Read/Write bit. If the bit was '1' (Read), a repeated START (SR) condition must be issued after the two sub-address bytes; if the bit is '0' (Write) the master will transmit to the slave with direction unchanged. [Table 10](#) explains how the SAD+Read/Write bit pattern is composed, listing all the possible configurations.

**Table 10. SAD+Read/Write patterns**

| Command | SAD[6:1] | SAD[0] = SA0 | R/W | SAD+R/W        |
|---------|----------|--------------|-----|----------------|
| Read    | 001100   | 0            | 1   | 00110001 (31h) |
| Write   | 001100   | 0            | 0   | 00110000 (30h) |
| Read    | 001100   | 1            | 1   | 00110011 (33h) |
| Write   | 001100   | 1            | 0   | 00110010 (32h) |

**Table 11. Transfer when master is writing one byte to slave**

|        |    |         |     |     |     |      |     |    |
|--------|----|---------|-----|-----|-----|------|-----|----|
| Master | ST | SAD + W |     | SUB |     | DATA |     | SP |
| Slave  |    |         | SAK |     | SAK |      | SAK |    |

**Table 12. Transfer when master is writing multiple bytes to slave:**

|        |    |         |     |     |     |      |     |      |     |    |
|--------|----|---------|-----|-----|-----|------|-----|------|-----|----|
| Master | ST | SAD + W |     | SUB |     | DATA |     | DATA |     | SP |
| Slave  |    |         | SAK |     | SAK |      | SAK |      | SAK |    |

**Table 13. Transfer when master is receiving (reading) one byte of data from slave:**

|        |    |         |     |     |     |    |         |     |      |      |    |
|--------|----|---------|-----|-----|-----|----|---------|-----|------|------|----|
| Master | ST | SAD + W |     | SUB |     | SR | SAD + R |     |      | NMAK | SP |
| Slave  |    |         | SAK |     | SAK |    |         | SAK | DATA |      |    |

**Table 14. Transfer when master is receiving (reading) multiple bytes of data from slave**

|        |    |       |     |     |     |    |       |     |      |     |       |     |       |      |    |
|--------|----|-------|-----|-----|-----|----|-------|-----|------|-----|-------|-----|-------|------|----|
| Master | ST | SAD+W |     | SUB |     | SR | SAD+R |     |      | MAK |       | MAK |       | NMAK | SP |
| Slave  |    |       | SAK |     | SAK |    |       | SAK | DATA |     | DAT A |     | DAT A |      |    |

Data are transmitted in byte format (DATA). Each data transfer contains 8 bits. The number of bytes transferred per transfer is unlimited. Data is transferred with the Most Significant bit (MSb) first. If a receiver can't receive another complete byte of data until it has performed some other function, it can hold the clock line, SCL LOW to force the transmitter into a wait state. Data transfer only continues when the receiver is ready for another byte and releases the data line. If a slave receiver doesn't acknowledge the slave address (i.e. it is not able to receive because it is performing some real time function) the data line must be left HIGH by the slave. The master can then abort the transfer. A LOW-to-HIGH transition on the SDA line while the SCL line is HIGH is defined as a STOP condition. Each data transfer must be terminated by the generation of a STOP (SP) condition.

In order to read multiple bytes, it is necessary to assert the most significant bit of the sub-address field. In other words, SUB(7) must be equal to 1 while SUB(6-0) represents the address of first register to be read.

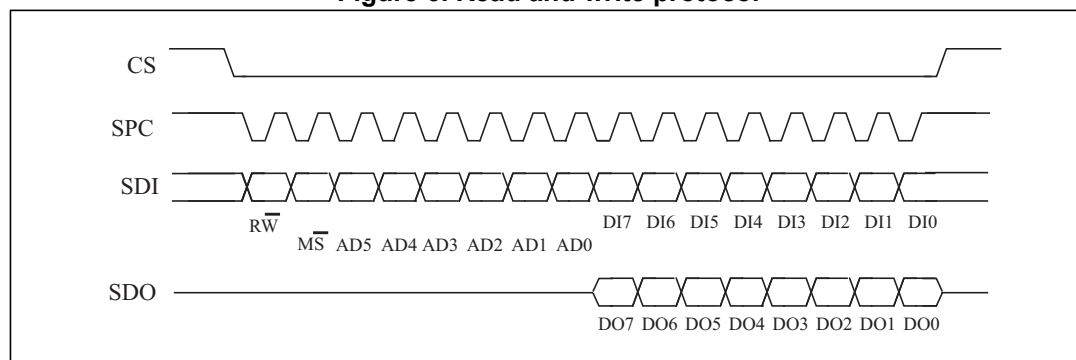
In the presented communication format MAK is Master acknowledge and NMAK is No Master Acknowledge.

## 5.2 SPI bus interface

The AIS3624DQ SPI is a bus slave. The SPI allows writing to and reading from the registers of the device.

The serial interface interacts with the outside world with 4 wires: **CS**, **SPC**, **SDI** and **SDO**.

**Figure 6. Read and write protocol**



**CS** is the serial port enable and it is controlled by the SPI master. It goes low at the start of the transmission and goes back high at the end. **SPC** is the serial port clock and it is controlled by the SPI master. It is stopped high when **CS** is high (no transmission). **SDI** and

**SDO** are respectively the serial port data input and output. Those lines are driven at the falling edge of **SPC** and should be captured at the rising edge of **SPC**.

Both the read register and write register commands are completed in 16 clock pulses or in multiple of 8 in the case of multiple read/write bytes. Bit duration is the time between two falling edges of **SPC**. The first bit (bit 0) starts at the first falling edge of **SPC** after the falling edge of **CS** while the last bit (bit 15, bit 23, ...) starts at the last falling edge of **SPC** just before the rising edge of **CS**.

**bit 0:**  $\overline{RW}$  bit. When 0, the data DI(7:0) is written into the device. When 1, the data DO(7:0) from the device is read. In latter case, the chip will drive **SDO** at the start of bit 8.

**bit 1:**  $\overline{MS}$  bit. When 0, the address will remain unchanged in multiple read/write commands. When 1, the address is auto incremented in multiple read/write commands.

**bit 2-7:** address AD(5:0). This is the address field of the indexed register.

**bit 8-15:** data DI(7:0) (write mode). This is the data that is written into the device (MSb first).

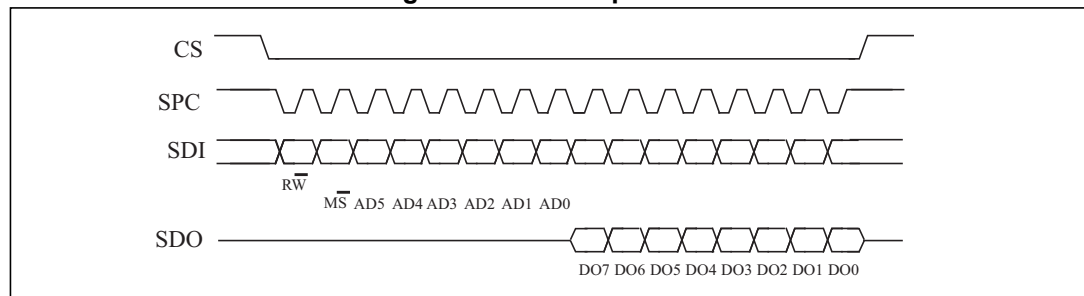
**bit 8-15:** data DO(7:0) (read mode). This is the data that is read from the device (MSb first).

In multiple read/write commands further blocks of 8 clock periods will be added. When the  $\overline{MS}$  bit is '0', the address used to read/write data remains the same for every block. When the  $\overline{MS}$  bit is '1', the address used to read/write data is increased at every block.

The function and the behavior of **SDI** and **SDO** remain unchanged.

### 5.2.1 SPI read

Figure 7. SPI read protocol



The SPI Read command is performed with 16 clock pulses. Multiple byte read command is performed adding blocks of 8 clock pulses at the previous one.

**bit 0:** READ bit. The value is 1.

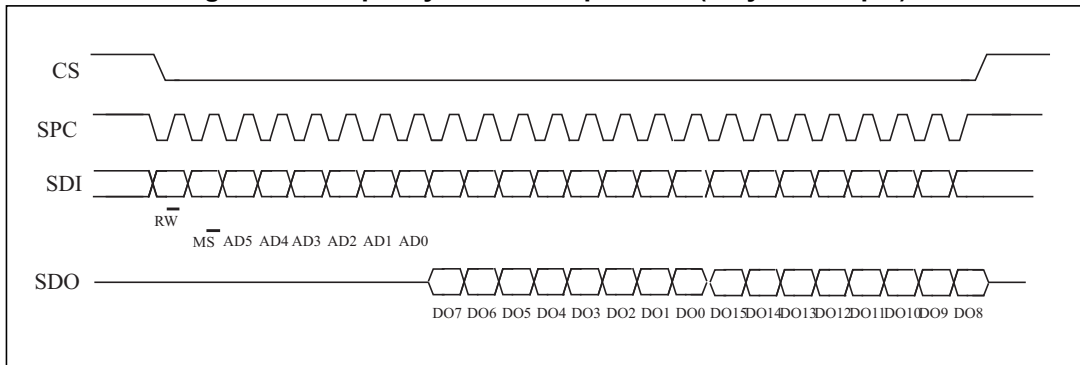
**bit 1:**  $\overline{MS}$  bit. When 0, does not increment the address; when 1, increments the address in multiple reads.

**bit 2-7:** address AD(5:0). This is the address field of the indexed register.

**bit 8-15:** data DO(7:0) (read mode). This is the data that will be read from the device (MSb first).

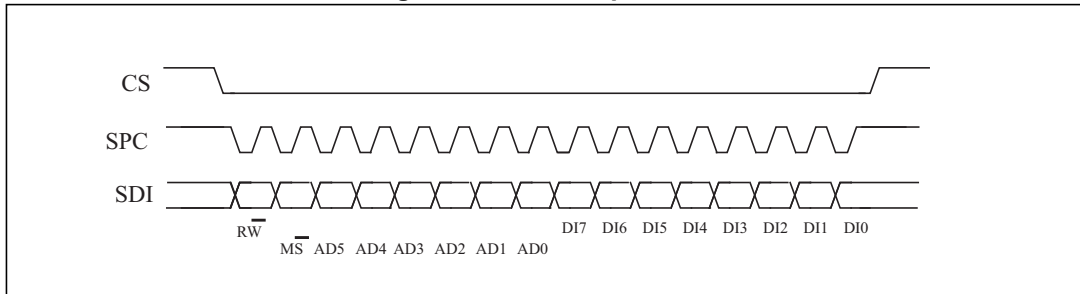
**bit 16-...** : data DO(...-8). Further data in multiple byte reads.

Figure 8. Multiple byte SPI read protocol (2-byte example)



5.2.2 SPI write

Figure 9. SPI write protocol



The SPI write command is performed with 16 clock pulses. A multiple byte write command is performed by adding blocks of 8 clock pulses to the previous one.

**bit 0:** WRITE bit. The value is 0.

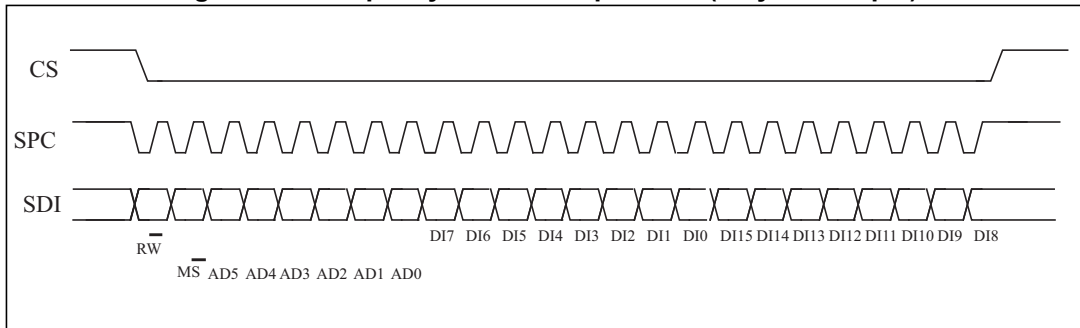
**bit 1:**  $\overline{MS}$  bit. When 0, does not increment the address; when 1, increments the address in multiple writes.

**bit 2 -7:** address AD(5:0). This is the address field of the indexed register.

**bit 8-15:** data DI(7:0) (write mode). This is the data that is written inside the device (MSb first).

**bit 16-...** : data DI(...-8). Further data in multiple byte writes.

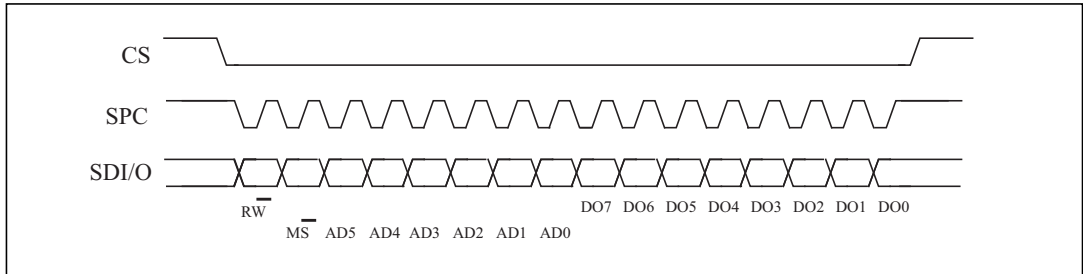
Figure 10. Multiple byte SPI write protocol (2-byte example)



### 5.2.3 SPI read in 3-wire mode

3-wire mode is entered by setting bit SIM to '1' (SPI serial interface mode selection) in CTRL\_REG4.

Figure 11. SPI read protocol in 3-wire mode



The SPI read command is performed with 16 clock pulses:

**bit 0:** READ bit. The value is 1.

**bit 1:**  $\overline{MS}$  bit. When 0, does not increment the address; when 1, increments the address in multiple reads.

**bit 2-7:** address AD(5:0). This is the address field of the indexed register.

**bit 8-15:** data DO(7:0) (read mode). This is the data that is read from the device (MSb first).

A multiple read command is also available in 3-wire mode.

## 6 Register mapping

The table given below provides a list of the 8-bit registers embedded in the device and the corresponding addresses.

**Table 15. Register address map**

| Name                     | Type | Register address |          | Default  | Comment        |
|--------------------------|------|------------------|----------|----------|----------------|
|                          |      | Hex              | Binary   |          |                |
| Reserved (do not modify) |      | 00 - 0E          |          |          | Reserved       |
| WHO_AM_I                 | r    | 0F               | 000 1111 | 00110010 | Dummy register |
| Reserved (do not modify) |      | 10 - 1F          |          |          | Reserved       |
| CTRL_REG1                | rw   | 20               | 010 0000 | 00000111 |                |
| CTRL_REG2                | rw   | 21               | 010 0001 | 00000000 |                |
| CTRL_REG3                | rw   | 22               | 010 0010 | 00000000 |                |
| CTRL_REG4                | rw   | 23               | 010 0011 | 00000000 |                |
| CTRL_REG5                | rw   | 24               | 010 0100 | 00000000 |                |
| HP_FILTER_RESET          | r    | 25               | 010 0101 |          | Dummy register |
| REFERENCE                | rw   | 26               | 010 0110 | 00000000 |                |
| STATUS_REG               | r    | 27               | 010 0111 | 00000000 |                |
| OUT_X_L                  | r    | 28               | 010 1000 | output   |                |
| OUT_X_H                  | r    | 29               | 010 1001 | output   |                |
| OUT_Y_L                  | r    | 2A               | 010 1010 | output   |                |
| OUT_Y_H                  | r    | 2B               | 010 1011 | output   |                |
| OUT_Z_L                  | r    | 2C               | 010 1100 | output   |                |
| OUT_Z_H                  | r    | 2D               | 010 1101 | output   |                |
| Reserved (do not modify) |      | 2E - 2F          |          |          | Reserved       |
| INT1_CFG                 | rw   | 30               | 011 0000 | 00000000 |                |
| INT1_SOURCE              | r    | 31               | 011 0001 | 00000000 |                |
| INT1_THS                 | rw   | 32               | 011 0010 | 00000000 |                |
| INT1_DURATION            | rw   | 33               | 011 0011 | 00000000 |                |
| INT2_CFG                 | rw   | 34               | 011 0100 | 00000000 |                |
| INT2_SOURCE              | r    | 35               | 011 0101 | 00000000 |                |
| INT2_THS                 | rw   | 36               | 011 0110 | 00000000 |                |
| INT2_DURATION            | rw   | 37               | 011 0111 | 00000000 |                |
| Reserved (do not modify) |      | 38 - 3F          |          |          | Reserved       |

Registers marked as *Reserved* must not be changed. Writing to those registers may cause permanent damage to the device. The content of the registers that are loaded at boot should not be changed. They contain the factory calibration values. Their content is automatically restored when the device is powered up.



## 7 Register description

The device contains a set of registers which are used to control its behavior and to retrieve acceleration data. The register address, made of 7 bits, is used to identify them and to write the data through the serial interface.

### 7.1 WHO\_AM\_I (0Fh)

Table 16. WHO\_AM\_I register

|   |   |   |   |   |   |   |   |
|---|---|---|---|---|---|---|---|
| 0 | 0 | 1 | 1 | 0 | 0 | 1 | 0 |
|---|---|---|---|---|---|---|---|

Device identification register.

This register contains the device identifier that for AIS3624DQ is set to 32h.

### 7.2 CTRL\_REG1 (20h)

Table 17. CTRL\_REG1 register

|     |     |     |     |     |     |     |     |
|-----|-----|-----|-----|-----|-----|-----|-----|
| PM2 | PM1 | PM0 | DR1 | DR0 | Zen | Yen | Xen |
|-----|-----|-----|-----|-----|-----|-----|-----|

Table 18. CTRL\_REG1 description

|           |   |
|-----------|---|
| PM2 - PM0 | Power mode selection. Default value: 000<br>(000: Power-down; Others: refer to <a href="#">Table 19</a> ) |
| DR1 - DR0 | Data rate selection. Default value: 00<br>(00: 50 Hz; Others: refer to <a href="#">Table 20</a> )         |
| Zen       | Z-axis enable. Default value: 1<br>(0: Z-axis disabled; 1: Z-axis enabled)                                |
| Yen       | Y-axis enable. Default value: 1<br>(0: Y-axis disabled; 1: Y-axis enabled)                                |
| Xen       | X axis enable. Default value: 1<br>(0: X-axis disabled; 1: X-axis enabled)                                |

The **PM** bits allow selecting between power-down and two operating active modes. The device is in power-down mode when the PD bits are set to “000” (default value after boot). [Table 19](#) shows all the possible power mode configurations and respective output data rates. Output data in the low-power modes are computed with low-pass filter cutoff frequency defined by the DR1 and DR0 bits.

The **DR** bits, in the normal-mode operation, select the data rate at which acceleration samples are produced. In low-power mode they define the output data resolution. [Table 20](#) shows all the possible configurations for the DR1 and DR0 bits.

Table 19. Power mode and low-power output data rate configurations

| PM2 | PM1 | PM0 | Power mode selection | Output data rate [Hz]<br>ODR <sub>LP</sub> |
|-----|-----|-----|----------------------|--|
| 0   | 0   | 0   | Power-down           | --   |
| 0   | 0   | 1   | Normal mode          | ODR  |
| 0   | 1   | 0   | Low-power            | 0.5  |
| 0   | 1   | 1   | Low-power            | 1  |
| 1   | 0   | 0   | Low-power            | 2  |
| 1   | 0   | 1   | Low-power            | 5  |
| 1   | 1   | 0   | Low-power            | 10   |

Table 20. Normal-mode output data rate configurations and low-pass cutoff frequencies

| DR1 | DR0 | Output Data Rate [Hz]<br>ODR | Low-pass filter cutoff<br>frequency [Hz] |
|-----|-----|------------------------------|--|
| 0   | 0   | 50                           | 37                                       |
| 0   | 1   | 100                          | 74                                       |
| 1   | 0   | 400                          | 292                                      |
| 1   | 1   | 1000                         | 780                                      |

### 7.3 CTRL\_REG2 (21h)

Table 21. CTRL\_REG2 register

| BOOT | HPM1 | HPM0 | FDS | HPen2 | HPen1 | HPCF1 | HPCF0 |
|------|------|------|-----|-------|-------|-------|-------|
|------|------|------|-----|-------|-------|-------|-------|

Table 22. CTRL\_REG2 description

|                 |  |
|-----------------|--|
| BOOT            | Reboot memory content. Default value: 0<br>(0: normal mode; 1: reboot memory content)  |
| HPM1, HPM0      | High-pass filter mode selection. Default value: 00<br>(00: normal mode; Others: refer to <a href="#">Table 23</a> )              |
| FDS             | Filtered data selection. Default value: 0<br>(0: internal filter bypassed; 1: data from internal filter sent to output register) |
| HPen2           | High-pass filter enabled for interrupt 2 source. Default value: 0<br>(0: filter bypassed; 1: filter enabled)                     |
| HPen1           | High-pass filter enabled for interrupt 1 source. Default value: 0<br>(0: filter bypassed; 1: filter enabled)                     |
| HPCF1,<br>HPCF0 | High-pass filter cutoff frequency configuration. Default value: 00<br>(00: HPC=8; 01: HPC=16; 10: HPC=32; 11: HPC=64)            |

The **BOOT** bit is used to refresh the content of internal registers stored in the flash memory block. At the device power-up the content of the flash memory block is transferred to the internal registers related to the trimming functions to allow correct behavior of the device itself. If for any reason the content of trimming registers is changed, it is sufficient to use this bit to restore the correct values. When the BOOT bit is set to '1', the content of internal flash is copied inside the corresponding internal registers and it is used to calibrate the device. These values are factory trimmed and they are different for every accelerometer. They allow correct behavior of the device and normally they have not to be changed. At the end of the boot process the BOOT bit is set again to '0'.

**Table 23. High-pass filter mode configuration**

| HPM1 | HPM0 | High-pass filter mode                          |
|------|------|--|
| 0    | 0    | Normal mode (reset by reading HP_RESET_FILTER) |
| 0    | 1    | Reference signal for filtering                 |
| 1    | 0    | Normal mode (reset by reading HP_RESET_FILTER) |

**HPCF[1:0]**. These bits are used to configure the high-pass filter cutoff frequency  $f_t$  which is given by:

$$f_t = \ln\left(1 - \frac{1}{\text{HPC}}\right) \cdot \frac{f_s}{2\pi}$$

The equation can be simplified to the following approximation:

$$f_t = \frac{f_s}{6 \cdot \text{HPC}}$$

**Table 24. High-pass filter cutoff frequency configuration**

| HPcoeff2,1 | $f_t$ [Hz]<br>Data rate = 50 Hz | $f_t$ [Hz]<br>Data rate = 100 Hz | $f_t$ [Hz]<br>Data rate = 400 Hz | $f_t$ [Hz]<br>Data rate = 1000 Hz |
|------------|---------------------------------|----------------------------------|----------------------------------|-----------------------------------|
| 00         | 1                               | 2                                | 8                                | 20                                |
| 01         | 0.5                             | 1                                | 4                                | 10                                |
| 10         | 0.25                            | 0.5                              | 2                                | 5                                 |
| 11         | 0.125                           | 0.25                             | 1                                | 2.5                               |

## 7.4 CTRL\_REG3 [interrupt CTRL register] (22h)

**Table 25. CTRL\_REG3 register**

|     |       |      |         |         |      |         |         |
|-----|-------|------|---------|---------|------|---------|---------|
| IHL | PP_OD | LIR2 | I2_CFG1 | I2_CFG0 | LIR1 | I1_CFG1 | I1_CFG0 |
|-----|-------|------|---------|---------|------|---------|---------|

**Table 26. CTRL\_REG3 description**

|                     |  |
|---------------------|--|
| IHL                 | Interrupt active high, low. Default value: 0<br>(0: active high; 1: active low)  |
| PP_OD               | Push-pull/Open-drain selection on interrupt pads. Default value 0.<br>(0: push-pull; 1: open-drain)  |
| LIR2                | Latch interrupt request on INT2_SRC register, with INT2_SRC register cleared by reading INT2_SRC itself. Default value: 0.<br>(0: interrupt request not latched; 1: interrupt request latched)       |
| I2_CFG1,<br>I2_CFG0 | Data signal on INT 2 pad control bits. Default value: 00.<br>(see table below)   |
| LIR1                | Latch interrupt request in the INT1_SRC register, with INT1_SRC register cleared by reading INT1_SRC register. Default value: 0.<br>(0: interrupt request not latched; 1: interrupt request latched) |
| I1_CFG1,<br>I1_CFG0 | Data signal on INT 1 pad control bits. Default value: 00.<br>(see table below)   |

**Table 27. Data signal on INT 1 and INT 2 pads**

| I1(2)_CFG1 | I1(2)_CFG0 | INT 1(2) Pad                             |
|------------|------------|--|
| 0          | 0          | Interrupt 1 (2) source                   |
| 0          | 1          | Interrupt 1 source OR interrupt 2 source |
| 1          | 0          | Data ready                               |
| 1          | 1          | Boot running                             |

## 7.5 CTRL\_REG4 (23h)

**Table 28. CTRL\_REG4 register**

|     |     |     |     |        |   |    |     |
|-----|-----|-----|-----|--------|---|----|-----|
| BDU | BLE | FS1 | FS0 | STsign | 0 | ST | SIM |
|-----|-----|-----|-----|--------|---|----|-----|

**Table 29. CTRL\_REG4 description**

|          |  |
|----------|--|
| BDU      | Block data update. Default value: 0<br>(0: continuous update; 1: output registers not updated between MSB and LSB reading) |
| BLE      | Big/little endian data selection. Default value 0.<br>(0: data LSB @ lower address; 1: data MSB @ lower address)           |
| FS1, FS0 | Full-scale selection. Default value: 00.<br>(00: $\pm 6 g$ ; 01: $\pm 12 g$ ; 11: $\pm 24 g$ )                             |
| STsign   | Self-test sign. Default value: 00.<br>(0: self-test plus; 1 self-test minus)   |
| ST       | Self-test enable. Default value: 0.<br>(0: self-test disabled; 1: self-test enabled)                                       |
| SIM      | SPI serial interface mode selection. Default value: 0.<br>(0: 4-wire interface; 1: 3-wire interface)                       |

The BDU bit is used to inhibit the update of the output registers until both upper and lower register parts are read. In default mode (BDU=0), the output register values are updated continuously. When the BDU is activated (BDU =1), the content of the output registers is not updated until both MSB and LSB are read which avoids reading values related to different sample times.

## 7.6 CTRL\_REG5 (24h)

Table 30. CTRL\_REG5 register

|   |   |   |   |   |   |         |         |
|---|---|---|---|---|---|---------|---------|
| 0 | 0 | 0 | 0 | 0 | 0 | TurnOn1 | TurnOn0 |
|---|---|---|---|---|---|---------|---------|

Table 31. CTRL\_REG5 description

|                     |   |
|---------------------|---|
| TurnOn1,<br>TurnOn0 | Turn-on mode selection for sleep-to-wake function. Default value: 00. |
|---------------------|---|

The **TurnOn** bits are used for turning on the **sleep-to-wake** function.

Table 32. Sleep-to-wake configuration

| TurnOn1 | TurnOn0 | Sleep-to-wake status   |
|---------|---------|--|
| 0       | 0       | Sleep-to-wake function is disabled                                       |
| 1       | 1       | Turned on: The device is in low power mode (ODR is defined in CTRL_REG1) |

Setting the TurnOn[1:0] bits to 11, the “sleep-to-wake” function is enabled. When an interrupt event occurs, the device returns to normal mode, increasing the ODR to the value defined in CTRL\_REG1. Although the device is in normal mode, CTRL\_REG1 content is not automatically changed to “normal mode” configuration.

## 7.7 HP\_FILTER\_RESET (25h)

Dummy register. Reading from this address zeroes instantaneously the content of the internal high-pass filter. If the high-pass filter is enabled, all three axes are instantaneously set to 0 g. This allows nullifying the settling time of the high-pass filter.

## 7.8 REFERENCE (26h)

**Table 33. REFERENCE register**

|      |      |      |      |      |      |      |      |
|------|------|------|------|------|------|------|------|
| Ref7 | Ref6 | Ref5 | Ref4 | Ref3 | Ref2 | Ref1 | Ref0 |
|------|------|------|------|------|------|------|------|

**Table 34. REFERENCE description**

|             |   |
|-------------|---|
| Ref7 - Ref0 | Reference value for high-pass filter. Default value: 00h. |
|-------------|---|

This register sets the acceleration value taken as a reference for the high-pass filter output. When the filter is turned on (at least one of the FDS, HPen2, or HPen1 bits is equal to '1'), and HPM bits are set to "01", the filter output is generated, taking this value as a reference.

## 7.9 STATUS\_REG (27h)

**Table 35. STATUS\_REG register**

|       |     |     |     |       |     |     |     |
|-------|-----|-----|-----|-------|-----|-----|-----|
| ZYXOR | ZOR | YOR | XOR | ZYXDA | ZDA | YDA | XDA |
|-------|-----|-----|-----|-------|-----|-----|-----|

**Table 36. STATUS\_REG description**

|       |   |
|-------|---|
| ZYXOR | X-, Y- and Z-axis data overrun. Default value: 0<br>(0: no overrun has occurred;<br>1: new data has overwritten the previous data before it was read) |
| ZOR   | Z-axis data overrun. Default value: 0<br>(0: no overrun has occurred;<br>1: new data for the Z-axis has overwritten the previous data)                |
| YOR   | Y-axis data overrun. Default value: 0<br>(0: no overrun has occurred;<br>1: a new data for the Y-axis has overwritten the previous data)              |
| XOR   | X-axis data overrun. Default value: 0<br>(0: no overrun has occurred;<br>1: new data for the X-axis has overwritten the previous data)                |
| ZYXDA | X-, Y- and Z-axis new data available. Default value: 0<br>(0: a new set of data is not yet available; 1: a new set of data is available)              |
| ZDA   | Z-axis new data available. Default value: 0<br>(0: new data for the Z-axis is not yet available;<br>1: new data for the Z-axis is available)          |
| YDA   | Y-axis new data available. Default value: 0<br>(0: new data for the Y-axis is not yet available;<br>1: new data for the Y-axis is available)          |
| XDA   | X-axis new data available. Default value: 0<br>(0: new data for the X-axis is not yet available;<br>1: new data for the X-axis is available)          |

**7.10 OUT\_X\_L (28h), OUT\_X\_H (29)**

X-axis acceleration data. The value is expressed as two's complement.

**7.11 OUT\_Y\_L (2Ah), OUT\_Y\_H (2Bh)**

Y-axis acceleration data. The value is expressed as two's complement.

**7.12 OUT\_Z\_L (2Ch), OUT\_Z\_H (2Dh)**

Z-axis acceleration data. The value is expressed as two's complement.

**7.13 INT1\_CFG (30h)****Table 37. INT1\_CFG register**

| AOI | 6D | ZHIE | ZLIE | YHIE | YLIE | XHIE | XLIE |
|-----|----|------|------|------|------|------|------|
|-----|----|------|------|------|------|------|------|

**Table 38. INT1\_CFG description**

|      |   |
|------|---|
| AOI  | AND/OR combination of Interrupt events. Default value: 0<br>(See <a href="#">Table 39</a> )   |
| 6D   | 6-direction detection function enable. Default value: 0<br>(See <a href="#">Table 39</a> )  |
| ZHIE | Enable interrupt generation on Z high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| ZLIE | Enable interrupt generation on Z low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |
| YHIE | Enable interrupt generation on Y high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| YLIE | Enable interrupt generation on Y low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |
| XHIE | Enable interrupt generation on X high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| XLIE | Enable interrupt generation on X low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |

Configuration register for Interrupt 1 source.

**Table 39. Interrupt 1 source configurations**

| AOI | 6D | Interrupt mode                      |
|-----|----|-------------------------------------|
| 0   | 0  | OR combination of interrupt events  |
| 0   | 1  | 6-direction movement recognition    |
| 1   | 0  | AND combination of interrupt events |
| 1   | 1  | 6-direction position recognition    |

## 7.14 INT1\_SRC (31h)

**Table 40. INT1\_SRC register**

|   |    |    |    |    |    |    |    |
|---|----|----|----|----|----|----|----|
| 0 | IA | ZH | ZL | YH | YL | XH | XL |
|---|----|----|----|----|----|----|----|

**Table 41. INT1\_SRC description**

|    |   |
|----|---|
| IA | Interrupt active. Default value: 0<br>(0: no interrupt has been generated; 1: one or more interrupts have been generated) |
| ZH | Z high. Default value: 0<br>(0: no interrupt, 1: Z high event has occurred)   |
| ZL | Z low. Default value: 0<br>(0: no interrupt; 1: Z low event has occurred)   |
| YH | Y high. Default value: 0<br>(0: no interrupt, 1: Y high event has occurred)   |
| YL | Y low. Default value: 0<br>(0: no interrupt, 1: Y low event has occurred)   |
| XH | X high. Default value: 0<br>(0: no interrupt, 1: X high event has occurred)   |
| XL | X low. Default value: 0<br>(0: no interrupt, 1: X low event has occurred)   |

Interrupt 1 source register. Read-only register.

Reading at this address clears the INT1\_SRC IA bit (and the interrupt signal on the INT 1 pin) and allows the refresh of data in the INT1\_SRC register if the latched option was chosen.

## 7.15 INT1\_THS (32h)

**Table 42. INT1\_THS register**

|   |      |      |      |      |      |      |      |
|---|------|------|------|------|------|------|------|
| 0 | THS6 | THS5 | THS4 | THS3 | THS2 | THS1 | THS0 |
|---|------|------|------|------|------|------|------|

**Table 43. INT1\_THS description**

|             |  |
|-------------|--|
| THS6 - THS0 | Interrupt 1 threshold. Default value: 000 0000 |
|-------------|--|



## 7.16 INT1\_DURATION (33h)

**Table 44. INT1\_DURATION register**

|   |    |    |    |    |    |    |    |
|---|----|----|----|----|----|----|----|
| 0 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---|----|----|----|----|----|----|----|

**Table 45. INT2\_DURATION description**

|         |   |
|---------|---|
| D6 - D0 | Duration value. Default value: 000 0000 |
|---------|---|

The **D6 - D0** bits set the minimum duration of the Interrupt 2 event to be recognized. Duration steps and maximum values depend on the ODR chosen.

## 7.17 INT2\_CFG (34h)

**Table 46. INT2\_CFG register**

|     |    |      |      |      |      |      |      |
|-----|----|------|------|------|------|------|------|
| AOI | 6D | ZHIE | ZLIE | YHIE | YLIE | XHIE | XLIE |
|-----|----|------|------|------|------|------|------|

**Table 47. INT2\_CFG description**

|      |   |
|------|---|
| AOI  | AND/OR combination of interrupt events. Default value: 0<br>(See <a href="#">Table 48</a> )   |
| 6D   | 6-direction detection function enable. Default value: 0<br>(See <a href="#">Table 48</a> )  |
| ZHIE | Enable interrupt generation on Z high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| ZLIE | Enable interrupt generation on Z low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |
| YHIE | Enable interrupt generation on Y high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| YLIE | Enable interrupt generation on Y low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |
| XHIE | Enable interrupt generation on X high event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value higher than preset threshold) |
| XLIE | Enable interrupt generation on X low event. Default value: 0<br>(0: disable interrupt request;<br>1: enable interrupt request on measured accel. value lower than preset threshold)   |

Configuration register for Interrupt 2 source.

**Table 48. Interrupt mode configuration**

| AOI | 6D | Interrupt mode                      |
|-----|----|-------------------------------------|
| 0   | 0  | OR combination of interrupt events  |
| 0   | 1  | 6-direction movement recognition    |
| 1   | 0  | AND combination of interrupt events |
| 1   | 1  | 6-direction position recognition    |

## 7.18 INT2\_SRC (35h)

**Table 49. INT2\_SRC register**

|   |    |    |    |    |    |    |    |
|---|----|----|----|----|----|----|----|
| 0 | IA | ZH | ZL | YH | YL | XH | XL |
|---|----|----|----|----|----|----|----|

**Table 50. INT2\_SRC description**

|    |   |
|----|---|
| IA | Interrupt active. Default value: 0<br>(0: no interrupt has been generated; 1: one or more interrupts have been generated) |
| ZH | Z high. Default value: 0<br>(0: no interrupt, 1: Z high event has occurred)   |
| ZL | Z low. Default value: 0<br>(0: no interrupt; 1: Z low event has occurred)   |
| YH | Y high. Default value: 0<br>(0: no interrupt, 1: Y high event has occurred)   |
| YL | Y low. Default value: 0<br>(0: no interrupt, 1: Y low event has occurred)   |
| XH | X high. Default value: 0<br>(0: no interrupt, 1: X high event has occurred)   |
| XL | X Low. Default value: 0<br>(0: no interrupt, 1: X low event has occurred)   |

Interrupt 2 source register. Read-only register.

Reading at this address clears the INT2\_SRC IA bit (and the interrupt signal on the INT 2 pin) and allows the refresh of data in the INT2\_SRC register if the latched option was chosen.

## 7.19 INT2\_THS (36h)

**Table 51. INT2\_THS register**

|   |      |      |      |      |      |      |      |
|---|------|------|------|------|------|------|------|
| 0 | THS6 | THS5 | THS4 | THS3 | THS2 | THS1 | THS0 |
|---|------|------|------|------|------|------|------|

**Table 52. INT2\_THS description**

|             |  |
|-------------|--|
| THS6 - THS0 | Interrupt 1 threshold. Default value: 000 0000 |
|-------------|--|

## 7.20 INT2\_DURATION (37h)

Table 53. INT2\_DURATION register

|   |    |    |    |    |    |    |    |
|---|----|----|----|----|----|----|----|
| 0 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---|----|----|----|----|----|----|----|

Table 54. INT2\_DURATION description

|         |   |
|---------|---|
| D6 - D0 | Duration value. Default value: 000 0000 |
|---------|---|

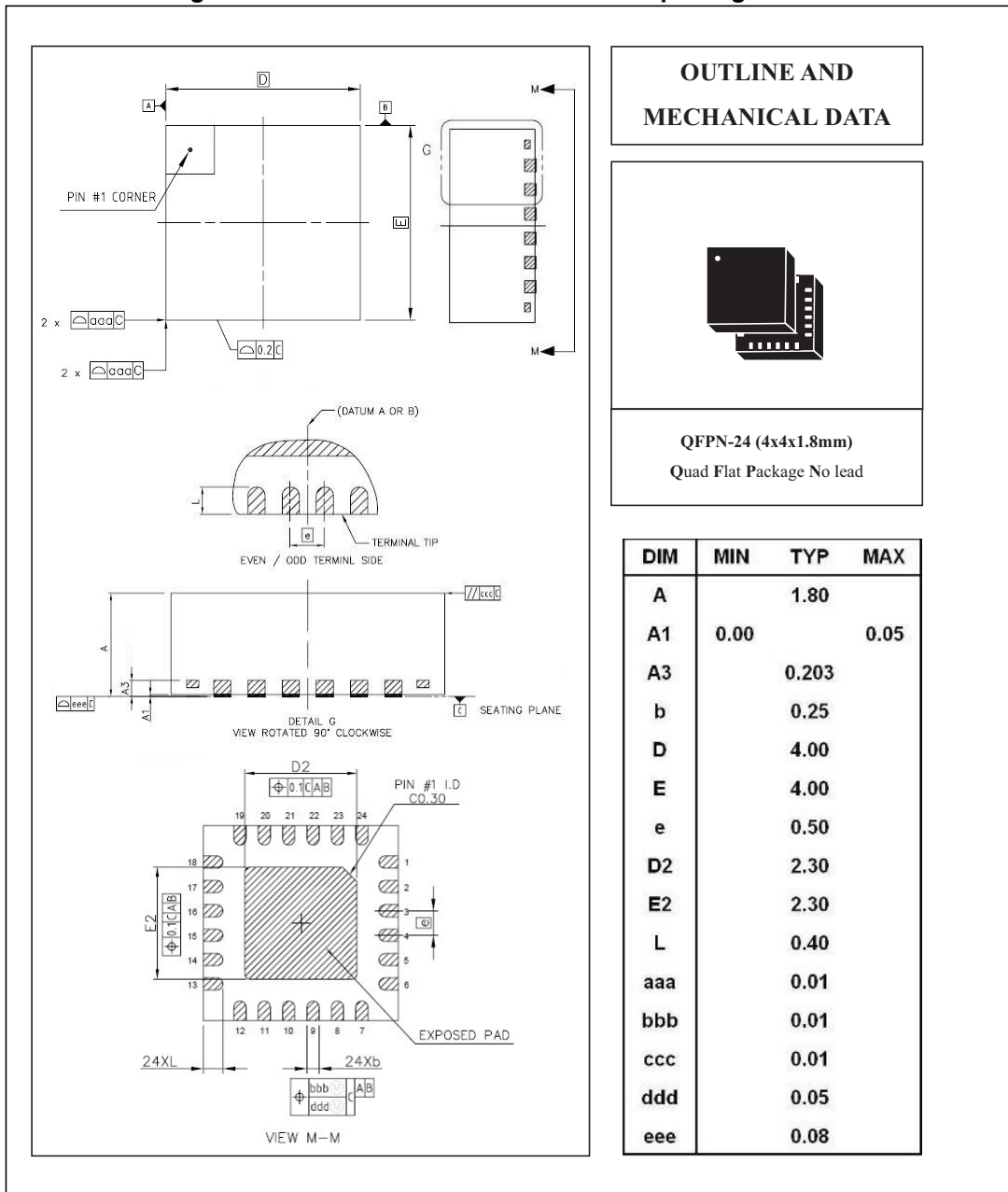
The **D6 - D0** bits set the minimum duration of the Interrupt 2 event to be recognized. Duration time steps and maximum values depend on the ODR chosen.

# 8 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

## 8.1 QFN 24L package information

Figure 12. QFN 24L: Mechanical data and package outline



## 9 Soldering information

The QFPN-24 package is compliant with the ECOPACK®, RoHS and “Green” standard. It is qualified for soldering heat resistance according to JEDEC J-STD-020C, in MSL3 conditions.

For complete land pattern and soldering recommendations, please refer to the technical note TN0019 available on [www.st.com](http://www.st.com).

### 9.1 General guidelines for soldering surface-mount MEMS sensors

The following three elements must be considered in order to adhere to common PCB design and good industrial practices when soldering MEMS sensors:

1. PCB with its own conductive layers (i.e. copper) and other organic materials used for board protection and dielectric isolation.
2. Accelerometer to be mounted on the board. The accelerometer senses acceleration, but it senses also the mechanical stress coming from the board. This stress is minimized with simple PCB design rules.
3. Soldering paste like Sn/Ag/Cu. This soldering paste can be dispensed on the board with a screen printing method through a stencil. The pattern of the soldering paste on the PCB is given by the stencil mask itself.

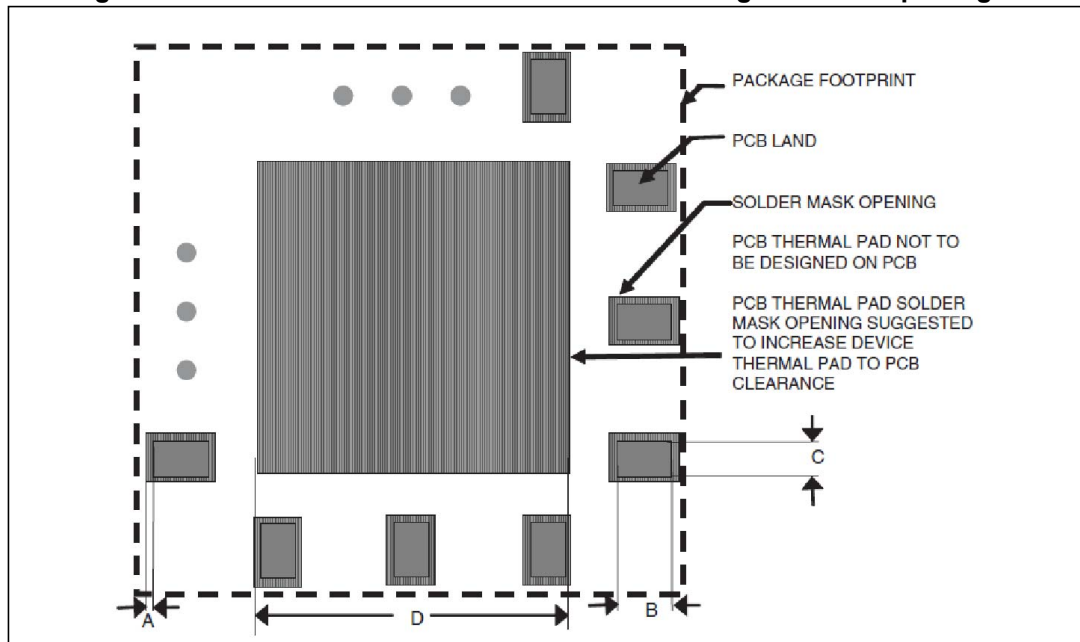
### 9.2 PCB design guidelines

PCB land and solder masking general recommendations are shown in [Figure 13](#). Refer to [Figure 12](#) for specific package size, land count and pitch.

- It is recommended to open solder mask external to PCB land;
- It is mandatory, for correct device functionality, to ensure that some clearance is present between the accelerometer thermal pad and PCB. In order to obtain this clearance it is recommended to open the PCB thermal pad solder mask
- The area below the sensor (on the same side of the board) must be defined as a keep-out area. It is strongly recommended to not place any structure on the top metal layer underneath the sensor;
- Traces connected to pads should be as symmetric as possible. Symmetry and balance for pad connection will help component self-alignment and will lead to a better control of solder paste reduction after reflow;
- For better performance over temperature it is strongly recommended not to place large insertion components like buttons or shielding boxes at distances less than 2 mm from the sensor
- Central die pad and “Pin 1 Indicator” are physically connected to GND. Leave “Pin 1 Indicator” unconnected during soldering.

### 9.3 PCB design rules

Figure 13. Recommended land and solder mask design for QFPN packages



**A** = Clearance from PCB land edge to solder mask opening  $\leq 0.1$  mm to ensure that some solder mask remains between PCB pads

**B** = PCB land length = QFPN solder pad length + 0.1 mm

**C** = PCB land width = QFPN solder pad width + 0.1 mm

**D** = PCB thermal pad solder mask opening = QFPN thermal pad side + 0.2 mm

The thermal pad must not be soldered.

### 9.4 Stencil design and solder paste application

The thickness and the pattern of the soldering paste are important for the proper device mounting process

- Stainless steel stencils are recommended for solder paste application;
- A stencil thickness of 125 - 150  $\mu\text{m}$  (5 - 6 mils) is recommended for screen printing;
- The final thickness of soldering paste should allow proper cleaning of flux residuals and clearance between sensor package and PCB;
- Stencil aperture should have a rectangular shape with dimension up to 25  $\mu\text{m}$  (1 mil) smaller than PCB land;
- The openings of the stencil for the signal pads should be between 50% and 80% of the PCB pad area;
- Optionally, for better solder paste release, the aperture walls should be trapezoidal and the corners rounded;
- The fine pitch of the IC leads requires accurate alignment of the stencil to the printed circuit board. The stencil and printed circuit assembly should be aligned to within 25  $\mu\text{m}$  (1 mil) prior to application of the solder paste.

## 9.5 Process considerations

- If self-cleaning solder paste is not used, it is mandatory to properly wash the board after soldering to eliminate any possible source of leakage between adjacent pads due to flux residues;
- The PCB soldering profile depends on the number, size and placement of components in the application board. The customer should use a time and temperature reflow profile that is derived from the PCB design and manufacturing specifications.

## 10 Revision history

Table 55. Document revision history

| Date        | Revision | Changes   |
|-------------|----------|---|
| 10-Nov-2014 | 1        | Initial release   |
| 14-Dec-2015 | 2        | Updated <i>Figure 5: AIS3624DQ electrical connections</i> |



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